

<b>Notice of References Cited</b>	Application/Control No. 10/528,993		Applicant(s)/Patent Under Reexamination MIKKONEN ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
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	M	US-			

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#### NON-PATENT DOCUMENTS

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*	U	Yoshioka et al, Mol. Cryst. and Liq. Cryst., 2000, 353, 59-73.			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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